



Material No.: 9346-05 Batch No.: 0000014416

Manufactured Date: 2012/08/22 Retest Date: 2017/08/21

Certificate of Analysis

Test	Specification	Result
Assay (HOCH2CH2OH) (by GC)	>= 99.0 %	100.0
Color (APHA)	<= 10	5
Acidity (µeq/g)	<= 0.8	0.4
Acidity (as CH ₃ COOH)(by wt)	<= 0.01 %	< 0.01
Residue after Ignition	<= 0.005 %	< 0.001
Water (H2O)(by Karl Fischer titrn)	<= 0.2 %	< 0.1
Chloride (CI)	<= 1 ppm	< 1
Phosphate (PO ₄)	<= 2 ppm	< 2
Sulfate (SO ₄)	<= 2 ppm	< 2
Arsenic and Antimony (as As)	<= 0.100 ppm	< 0.100
Trace Impurities - Iron (Fe)	<= 0.2 ppm	0.0
Trace Impurities - Aluminum (Al)	<= 100.0 ppb	< 5.0
Trace Impurities - Barium (Ba)	<= 100.0 ppb	< 1.0
Trace Impurities - Boron (B)	<= 50.0 ppb	< 5.0
Trace Impurities - Calcium (Ca)	<= 300.0 ppb	19.1
Trace Impurities - Chromium (Cr)	<= 50.0 ppb	< 1.0
Trace Impurities - Copper (Cu)	<= 10.0 ppb	< 1.0
Trace Impurities - Gold (Au)	<= 50.0 ppb	< 5.0
Trace Impurities - Lead (Pb)	<= 200.0 ppb	5.1
Trace Impurities - Lithium (Li)	<= 100.0 ppb	< 1.0
Trace Impurities - Magnesium (Mg)	<= 100.0 ppb	3.7
Trace Impurities - Manganese (Mn)	<= 100.0 ppb	< 1.0
Trace Impurities - Nickel (Ni)	<= 100.0 ppb	< 5.0
Trace Impurities - Potassium (K)	<= 300.0 ppb	< 10.0

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Test	Specification	Result
Trace Impurities - Sodium (Na)	<= 300.0 ppb	11.0
Trace Impurities - Tin (Sn)	<= 100.0 ppb	< 10.0
Trace Impurities - Titanium (Ti)	<= 100.0 ppb	< 1.0
Trace Impurities – Zinc (Zn)	<= 400.0 ppb	18.9
Particle Count - 0.5 µm and greater	<= 200 par/ml	20
Particle Count - 1.0 µm and greater	<= 10 par/ml	5

For Microelectronic Use

Country of Origin: US

Packaging Site: Paris Mfg Ctr & DC



Phillipsburg, NJ 9001.2008, 14001.2004 Paris, KY 9001.2008 Mexico city, Mexico 9001.2008 Deventer, The Netherlands 9001.2008, 14001.2004 Selangor, Malaysia 9001.2008 Panoli, India 9001.2008 Gliwice, Poland 9001.2008,17025.2005

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